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| <b>Notice of References Cited</b> | Application/Control No.<br>10/663,103 |  | Applicant(s)/Patent Under<br>Reexamination<br>REED ET AL. |             |
|                                   | Examiner<br>RAYMOND S. DEAN           |  | Art Unit<br>2618                                          | Page 1 of 1 |

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|   | B | US-                                              |                 |             |                |
|   | C | US-                                              |                 |             |                |
|   | D | US-                                              |                 |             |                |
|   | E | US-                                              |                 |             |                |
|   | F | US-                                              |                 |             |                |
|   | G | US-                                              |                 |             |                |
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|   | L | US-                                              |                 |             |                |
|   | M | US-                                              |                 |             |                |

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|   | X |                                                                                           |

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